

Notice of References Cited	Application/Control No. 10/553,684		Applicant(s)/Patent Under Reexamination YATABE, FUMIO	
	Examiner Hai H. Huynh		Art Unit 3747	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,975,739 A	11-1999	Katayama et al.	700/90
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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